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Performance improvement of MXene-based perovskite solar cells upon property transition from metallic to semiconductive by oxidation of $Ti_3C_2T_x$ in air†

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The unique properties of MXenes that arise from terminating functional groups and oxidation of MXenes make them attractive for application in photovoltaic devices like perovskite solar cells (PSCs). Here, oxidation of $Ti_3C_2T_x$ hydrocolloid was carried out to tune its properties desirable for an electron transport layer (ETL) in low-temperature processed PSCs. The calculations of the energy levels were carried out using the Vienna *ab initio* simulation package (VASP) code based on density functional theory (DFT). Oxidation of $Ti_3C_2T_x$ can generate Ti-O bonds and effectively reduce the macroscopic defects of the film fabricated by spin-coating, while a transition from metallic material to semiconductor occurred after heavy oxidation. A better matching of energy levels between perovskite and ETL layer in the case of a hybrid of oxidized and pristine $Ti_3C_2T_x$ renders a champion power conversion efficiency (PCE) of 18.29%. The improvement in PCE can be attributed to the increased electron mobility in the ETL, which promotes electron transport and reduces the electron-hole recombination. Hence, by presenting a simple method for high performance in PSCs by MXene-derived materials, this work demonstrates the great potential of these materials for applications in low-temperature processed PSCs and other photovoltaic technologies.

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Introduction

The rapid development of organic–inorganic lead halide perovskite solar cells (PSCs) has gained enormous attention. They are promising candidates owing to their high mobility, appropriate bandgap, long carrier diffusion length and strong absorption coefficients in the visible spectrum. The power conversion efficiency (PCE) has risen from 3.8% to 25.5%, demonstrating the immense potential of this competitive photovoltaic technology. In the PSCs, the electron transport layer (ETL) is an essential component in restraining charge

recombination and rectifying the photocurrent.⁷ The traditional mesoporous structured PSCs based on TiO₂ as ETL usually deliver high efficiency and stable power output, but the need of sintering limits their utilization. Low-temperature processed PSCs are more promising due to their simple fabrication and low cost.⁸⁻¹⁰ Recently, two-dimensional (2D) materials have attracted attention for application in low-temperature processed PSCs.^{11,12} For example, Jokar *et al.* reported rGO-based inverted PSC with a PCE of 16%.¹³ Fu *et al.* explored ultrasmall black phosphorus quantum dots as ETL in PSCs, and a maximum PCE of 11.26% was achieved for the devices based on flexible substrates.¹⁴ Singh *et al.* explored MoS₂ as ETL and achieved a PCE of 13.14%, and Yin *et al.* obtained a PCE of 17.37% using 2D TiS₂ as ETL for planar PSCs.^{15,16}

MXenes are 2D transition metal carbides and nitrides with a formula of $M_{n+1}X_nT_x$, where M represents an early transition metal, X indicates carbon and/or nitrogen, and T_x represents the surface terminations (usually –O, –OH and/or –F).^{17,18} Owing to their excellent electrical conductivity, flexibility, hydrophilicity and rich and tunable surface chemistry,^{19,20} MXenes have been explored in supercapacitors,²¹ lithium-ion batteries,²² sensors,²³ electromagnetic interference shielding²⁴ and catalysis.²⁵ In addition, the oxidation and environmental stability

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 $[\]dagger$ Electronic supplementary information (ESI) available: XPS analysis, J-V curves, photovoltaic parameters based on HO-Ti $_3$ C $_2$ T $_x$ @Ti $_3$ C $_2$ T $_x$ with different volume ratio, PL results, SCLC results, EIS fitting parameters and stability results of PSCs. See DOI: 10.1039/d0ta11397b

have been extensively studied. New applications in energy and catalysis emerged for partially oxidized MXenes.26 Moreover, applications of Ti₃C₂T_x in solar cells have also been explored. Ti₃C₂T_x, which has metallic conductivity, has been applied as electrode in dye-sensitized solar cells and as an additive to perovskite layer or ETLs for perovskite solar cells.27-29 Ti₃C₂T_x has also been employed as an interfacial layer to optimize the interface band alignment between perovskite and ETL, resulting in a PCE exceeding 20%.30 Yu et al. tested Ti₃C₂T_x as electron- and hole-transport layers in organic solar cells and a PCE of 9.06% was achieved.31 Besides, a multi-dimensional conductive heterojunction structure, composited of TiO2, SnO₂, and Ti₃C₂T_x MXene was designed and applied as ETL by Huang et al., achieving 19.14% PCE.32 The work function tuning of Ti₃C₂T_r by controlling the surface termination group was demonstrated by Schultz et al.33 and used by Di Vito et al. to achieve better matching of energy levels and effective charge transport.34 Our previous work showed that UV-ozone treatment of Ti₃C₂T_x can effectively generate oxide-like Ti-O bonds, rendering it suitable as ETL in PSCs and a PCE of 17.17% was demonstrated.35 The removal of OH terminations and formation of Ti-O bonds can effectively improve the interface properties of the Ti₃C₂T_x/perovskite junction and result in better PCE, which aroused our interest in exploring Ti₃C₂T_x oxidized to varying degrees as ETLs for PSCs.

In this work, Ti₃C₂T_r colloidal solution in water was placed onto a hot plate at 50 °C under continuous magnetic stirring in ambient air to control its oxidation process. Varying degrees of oxidation of Ti₃C₂T_x were prepared, including lightly oxidized Ti₃C₂T_x (LO- $Ti_3C_2T_x$) and heavily oxidized $Ti_3C_2T_x$ (HO- $Ti_3C_2T_x$), as well as a composite of heavily oxidized $Ti_3C_2T_x$ with pristine $Ti_3C_2T_x$ (HO-Ti₃C₂T_x@Ti₃C₂T_x). These nanomaterials were spin-coated on indium tin oxide (ITO) substrates to serve as ETLs for the lowtemperature processed PSCs with the structure of ITO/ETL/CH3-NH₃PbI₃/spiro-OMeTAD/Ag. Scanning electron microscopy (SEM), transmission electron microscopy (TEM) and X-ray photoelectron spectroscopy (XPS) indicate that appropriate oxidation of Ti₃C₂T_x can reduce the macroscopic defects of the film, generate more Ti-O bonds and render the material more suitable as ETLs in PSCs. Moreover, the computational analysis of oxidized $Ti_3C_2T_x$ was conducted using the Vienna ab initio simulation package (VASP) code based on density functional theory (DFT). A transition from metallic material to semiconductor for Ti₃C₂T_x occurred by oxidation, while a better matching of energy levels was obtained. The device based on HO-Ti₃C₂T_x@Ti₃C₂T_x showed an increase in short-circuit current density (J_{sc}) and fill factor (FF), resulting in PCE of 18.29%. A better surface homogeneity of the film and decreased electron-hole recombination at the ETL/perovskite interface enhanced the electron mobility and further promoted electron transport, resulting in improvement of PCE.

Experimental section

Materials

Methylammonium iodide (CH₃NH₃I, >99.5%), lead iodide (PbI₂, >99.99%) and lithium-bis(trifluoromethanesulfonyl)imide (Li-TFSI, >99%) were purchased from Xian Polymer Light Technology Corp.

2,2′,7,7′-Tetrakis-(*N*,*N*-di-*p*-methoxyphenylamino)-9,9′-spirobifluorene (spiro-OMeTAD, >99.8%), 4-*tert*-butyl pyridine (*t*BP, 96%) and ultra-dry anhydrous *N*,*N*-dimethylformamide (DMF, 99.8%) and dimethyl sulfoxide (DMSO, 99.7%) were purchased from Sigma Aldrich. For MAX phase synthesis, titanium powder and aluminum powder were purchased from Aladdin. Graphite was purchased from Sigma Aldrich.

Preparation of Ti₃C₂T_x MXene colloidal solution

The method is the same as our previous report.35 The mixture of titanium powder (7.368 g), aluminum powder (1.523 g) and graphite (1.109 g) was sintered at 1650 °C for 2 hours under argon to prepare Ti₃AlC₂ MAX phase. Then we used a mortar-pestle to grind the Ti₃AlC₂ MAX powder and make it pass through the 400 mesh sieve. The obtained uniform Ti₃AlC₂ MAX powder was added into 12 M LiF/9 M HCl solution at room temperature. Specifically, 1.6 g LiF was added while continuously stirring 20 mL of 9 M HCl solution at room temperature and stirred for a few minutes. Then 1.0 g Ti₃AlC₂ MAX powder was gradually added (about 5 min) to the etchant solution and continuously etched for 24 h at room temperature. When the etching process was finished, the obtained acid mixture was repeatedly washed with deionized water by centrifugation (5 min per cycle at 8000 rpm) until the pH of mixture was over 5. Finally, the slurry was placed in ultrasound for 30 min in an ice bath under argon and centrifuged at 3500 rpm for 1 h. The obtained supernatant was the colloid solution of Ti₃C₂T_x nanosheets. To confirm and control the concentration, a known quantity of solution was filtered over a cellulose membrane (0.22 μ m pore size). After weighing the peeled-off dried $Ti_3C_2T_r$ film, the concentration of Ti₃C₂T_x was determined, and also could be tuned.

Oxidation of MXene and preparation of solutions for ETL

By diluting the as-prepared highly concentrated $Ti_3C_2T_x$ dispersion with deionized water, the $Ti_3C_2T_x$ colloidal solution with an appropriate concentration of 3 mg mL⁻¹ was obtained. Then the colloidal solution was placed on a hot plate at 50 °C under continuously stirring for 48 h to obtain LO- $Ti_3C_2T_x$ and 120 h to obtain HO- $Ti_3C_2T_x$. The HO- $Ti_3C_2T_x$ @ $Ti_3C_2T_x$ were obtained by mixing the two solutions together directly in a certain proportion and stirring for 5 min before using. Unless specified otherwise, the HO- $Ti_3C_2T_x$ @ $Ti_3C_2T_x$ data presented in this article were obtained with the composite with a 5 : 1 ratio (HO- $Ti_3C_2T_x$: $Ti_3C_2T_x$).

Device fabrication

The detailed method for the device fabrication referred to our previous work. The pre-patterned ITO-coated substrates were washed by ultrasonication with deionized water, acetone, alcohol, and isopropanol for 30 min respectively, then dried and treated with UV ozone for 30 min. To fabricate ETLs, $\rm Ti_3C_2T_x$ colloid and the composites of oxidized $\rm Ti_3C_2T_x$ and $\rm Ti_3C_2T_x$ were prepared $\it via$ spin-coating 80 $\rm \mu L$ of the colloid onto the ITO substrates at 2500 rpm for 60 s in air, followed by thermal annealing on a hot plate at 100 °C for 30 min and UV ozone treatment for 30 min. Then the samples were moved into a glovebox filled with argon to fabricate the perovskite (CH₃NH₃PbI₃)

layer, whose precursor solution was prepared by mixing 1.3 M (242 mg) PbI₂ and 1.3 M (83 mg) CH₂NH₃I in 408 μL DMF/DMSO (4:1 volume ratio) and stirring for more than 60 min. The perovskite layer was prepared by depositing its precursor solution (45 μL) via spin-coating at 5000 rpm for 30 s onto the ETL, and 350 µL chlorobenzene was injected quickly onto the film in 5 s during the spin-coating process. The obtained film was then annealed at 100 °C for 10 min on a hot plate. After that, the spiro-OMeTAD was dissolved in chlorobenzene (80 mg mL⁻¹) under continuous stirring for 20 min. Then, 10.5 µL of tBP and 15.5 µL of a Li-TFSI solution (510 mg Li-TFSI/1 mL acetonitrile) were added into 1 mL solution and spin-coated onto the perovskite layer at a speed of 4000 rpm for 30 s. Then the samples were kept in the dark at room temperature overnight in dry air. Finally, 60 nm Ag electrode was deposited on the top of spiro-OMeTAD by thermal evaporation.

Simulation characterization

The calculations were carried out by the Vienna *ab initio* simulation package (VASP) code based on density functional theory (DFT). The exchange–correlation function based on generalized gradient approximation (GGA) with the Perdue–Burke–Ernzerhof (PBE) was employed. The ion–electron interaction was treated by the projector augmented wave (PAW) method. The energy cutoff was set at 500 eV, the Brillouin-zone integrations and the magnitude of the force acting on each atom became less than 0.01 eV $\rm \mathring{A}^{-1}$. The Brillouin zone was represented by Monkhorst–Pack special k-point mesh of 5 \times 5 \times 1 for geometry optimizations of

 $Ti_3C_2T_x$ (X = O; F; OH), 20%-oxidized $Ti_3C_2T_x$, 80%-oxidized $Ti_3C_2T_x$, HO- $Ti_3C_2T_x$ @ $Ti_3C_2T_x$ composite, and $9 \times 9 \times 9$ for TiO_2 bulk, respectively. The positions of atoms and the cell parameters were fully optimized by using the conjugate gradient method and the total energy of the optimized structures were well converged to 10^{-6} eV per cell. The electronic structures including density of states (DOS) and band gap were obtained using k point of $11 \times 11 \times 1$ Monkhorst–Pack k-point grid. A large vacuum space of 15 Å was used for avoiding any interaction between MXene layers. Besides, the van der Waals interaction was considered, and DFT+U correction was used during our calculations with the U value of 3 V for Ti atoms.

The relaxed lattice parameters for TiO_2 bulk was a=b=4.67 Å, c=3.03 Å while a=b=3.10 Å for $Ti_3C_2T_x$, respectively, which were all in consistent with previous experimental and theoretical values.³⁶ The structure of TiO_2 – $Ti_3C_2T_x$ heterojunction was constructed by a 2 × 2 (010) surface of TiO_2 and a 1 × 1 (001) surface of $Ti_3C_2T_x$. Besides, 20%-oxidized $Ti_3C_2T_x$ for LO- $Ti_3C_2T_x$, 80%-oxidized $Ti_3C_2T_x$ for HO- $Ti_3C_2T_x$ were constructed with the model of surface inside heterojunction.^{37,38}

Thin film characterization

The UV-ozone treatment was employed by BZS250GF-TS UV-ozone cleaner. The UV/vis absorption spectra of ETLs films were characterized by a Shimadzu UV-1900 spectrophotometer over the 300–1000 nm wavelength range. ETLs were coated on glass then their crystal structures were characterized by X-ray diffraction (XRD) (Brucker D8 X-ray diffractometer) with Cu K α radiation (λ = 1.5418

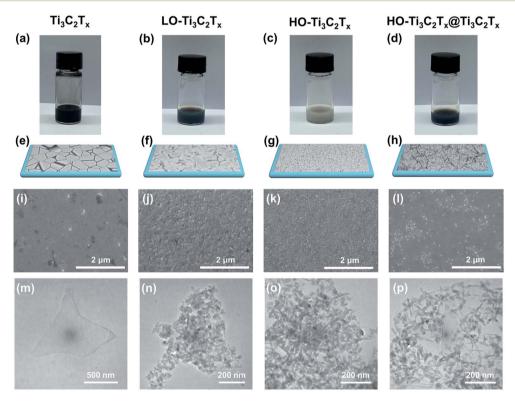


Fig. 1 Oxidation of $Ti_3C_2T_x$ MXene in solution. (a–d) Digital photos of $Ti_3C_2T_x$, LO- $Ti_3C_2T_x$, HO- $Ti_3C_2T_x$ and HO- $Ti_3C_2T_x$ @ $Ti_3C_2T_x$ hydrocolloid. (e–h) Schematic representations and (i–l) SEM images of $Ti_3C_2T_x$, LO- $Ti_3C_2T_x$, HO- $Ti_3C_2T_x$ and HO- $Ti_3C_2T_x$ @ $Ti_3C_2T_x$ films deposited on the ITO substrate by spin-coating. (m–p) TEM images of $Ti_3C_2T_x$, LO- $Ti_3C_2T_x$, HO- $Ti_3C_2T_x$ and HO- $Ti_3C_2T_x$ @ $Ti_3C_2T_x$, respectively.

Å) at room temperature. The data was collected with a 0.02° step size (2θ) for 0.2 s. Raman spectra were obtained by Raman spectroscopy (Spex 1403) with a 514 nm laser to identify the molecular structure. XPS measurements were performed using Thermo Fischer ESCA-LAB 250Xi. SEM images were acquired by a field emission scanning electron microscope (Hitachi SU8000). TEM images were recorded using a JEM-2200FS (JEOL). Steady-state photoluminescence (PL) was carried out by Shimadzu RF-5301PC spectrophotometer with excitation at 403 nm on the perovskite surface. Time-resolved photoluminescence (TRPL) spectra were carried out by a PL spectrometer (Edinburgh Instruments, FLS 920). Ultraviolet photoelectron spectra (UPS) were determined by PHI5000 VersaProbe III (scanning ESCA microprobe) SCA (Spherical Analyzer).

Device characterization

The J-V characteristics of perovskite solar cells were measured by a Keithley 2400 source meter measurement system with an AM 1.5 G filter at an illumination intensity of 100 mW cm⁻². The effective area of the cells was confirmed to be 0.04 cm² using a non-reflective metal mask. The EQE spectra were measured in air under short-circuit conditions using SOFN 7-SCSpecIII equipped with a 100 W Xe arc lamp, a filter wheel, and a monochromator. Monochromatic light was chopped at a frequency of 80 Hz and photocurrents were measured using a lock-in amplifier. The setup was calibrated using a certified silicon reference diode of known spectral response. The electrochemical impedance spectroscopy (EIS) measurements on the devices were carried out by a VSP multi-channel potentiostat (Biologic, France), under the standard AM 1.5 G (100 mW cm⁻²) simulated sunlight illumination at open-circuit potential with the frequency ranging between 1 MHz and 10 Hz. Z-View Analyst software was used to model the Nyquist plots obtained from the impedance measurements.

Results and discussion

In situ oxidation of Ti₃C₂T_r nanosheets and characterization of the films

The Ti₃C₂T_r MXene nanosheets were fabricated following our previous work by etching the Al layers from Ti₃AlC₂ MAX phase and exfoliating the MXene via the minimally intensive layer delamination (MILD) method.39 Then, the Ti₃C₂T_x colloidal solution was placed on a hot plate at 50 °C under continuous stirring to oxidize it. The photos of different samples after oxidation are shown in Fig. 1a-d. As the stirring time increases to 48 h, partial oxidation occurred and the initial dark black color of the $Ti_3C_2T_x$ colloid solution became lighter (see Fig. 1b), named as LO-Ti₃C₂T_x. After 120 h of stirring, the Ti₃C₂T_x has been mostly oxidized and the dark colloid solution turned to grey, which is shown in Fig. 1c and named as HO-Ti₃C₂T_x. Mixtures of HO-Ti₃C₂T_x and pristine Ti₃C₂T_x solutions were prepared in different proportions directly to obtain the composites of HO-Ti₃C₂T_x and Ti₃C₂T_x (HO-Ti₃C₂T_x@Ti₃C₂T_x). The photo of the composite with a ratio 5:1 (HO-Ti₃C₂T_x-: Ti₃C₂T_x) is shown in Fig. 1d. Fig. 1e, f, g and h show the schematic representations of Ti₃C₂T_x, LO-Ti₃C₂T_x, HO-Ti₃C₂T_x and HO-Ti₃C₂T_x@Ti₃C₂T_x films deposited on the ITO substrate by spin-coating, respectively. Oxidation is confirmed by XRD and Raman spectra, which are discussed later. The corresponding SEM images of four kinds of films are shown in Fig. 1i–l. As can be seen in the figures, there were some pinholes in the Ti₃C₂T_x film and the substrate was not fully covered by the nanosheets, which can easily result in short-circuit. As the

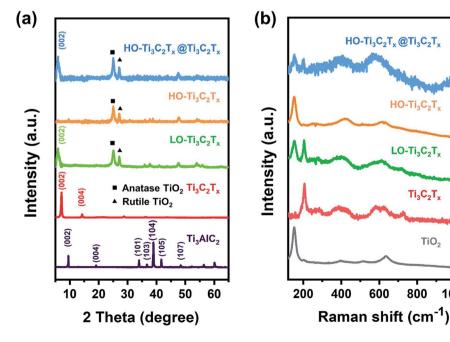


Fig. 2 (a) XRD patterns of Ti_3AlC_2 powder and the dried films of $Ti_3C_2T_x$, $LO-Ti_3C_2T_x$, $HO-Ti_3C_2T_x$, $HO-Ti_3C_2T_x$ @ $Ti_3C_2T_x$. (b) Raman patterns of $Ti_3C_2T_x$, LO- $Ti_3C_2T_x$, HO- $Ti_3C_2T_x$, HO- $Ti_3C_2T_x$ @ $Ti_3C_2T_x$ and TiO_2 films.

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degree of oxidation increased, nanoparticles grew on the $Ti_3C_2T_r$ nanosheets. The surface of LO- $Ti_3C_2T_r$ was partially transformed, but still kept the laminated structure while the surface of HO-Ti₃C₂T_r film was fully covered with nanoparticles, as shown in Fig. 1k. The film of HO-Ti₃C₂T_r(a)Ti₃C₂T_r, as shown in Fig. 1l, exhibited pin-holes-free surface where nanoparticles were tiled on the Ti₃C₂T_x nanosheets uniformly. It can be observed that the oxidation significantly reduced the defects, improved flatness and homogeneity of the film surface. TEM images of Ti₃C₂T_x, LO-Ti₃C₂T_x, HO-Ti₃C₂T_x and HO-Ti₃C₂T_x@-Ti₃C₂T_x are shown in Fig. 1m-p. Nanoparticles appeared gradually as the oxidation process progressed, leading to varying degrees of breaking down of the laminated structure, and ended up as almost nanoparticles (about 40-50 nm) in the case of HO-Ti₃C₂T_x while the HO-Ti₃C₂T_x@Ti₃C₂T_x exhibited a good combination of nanoparticles and Ti₃C₂T_x nanosheets. These TEM results were highly consistent with SEM images.

To further determine the structural changes, XRD patterns and Raman spectra of these films were recorded and are shown in Fig. 2. As one can see from Fig. 2a, the most intense peak at 38.9° (2θ) of Ti_3AlC_2 disappeared and the (002) peak shifted from 9.5° to about 7° after 24 h etching, indicating formation of $Ti_3C_2T_x$. As the degree of oxidation increased, new peaks appeared at about 25.3° and 27.2° corresponding to anatase and rutile TiO_2 , respectively. The peak of $Ti_3C_2T_x$ at about 7° shifted to about 6° , indicating LO- $Ti_3C_2T_x$ had a wider interlayer

distance according to the Bragg equation, which is assumed to be due to the oxidized nanoparticles. When $\mathrm{Ti_3C_2T_x}$ was highly oxidized (HO- $\mathrm{Ti_3C_2T_x}$), the (002) peak disappeared, while the peaks corresponding to anatase and rutile $\mathrm{TiO_2}$ remained. The composites of $\mathrm{HO-Ti_3C_2T_x}$ and $\mathrm{Ti_3C_2T_x}$ and $\mathrm{HO-Ti_3C_2T_x}$, demonstrating a good mixing. Raman spectra in Fig. 2b also exhibit the same tendency as XRD patterns. Besides, the pattern of $\mathrm{HO-Ti_3C_2T_x}$ was highly similar to that of the $\mathrm{TiO_2}$, proving that formed nanoparticles were $\mathrm{TiO_2}$. These results and UV-Vis absorption spectra (Fig. S1†) are also in agreement with the SEM and TEM images.

To get insight into the chemical changes and bonding occurring in association with the oxidation of ${\rm Ti_3C_2T_x}$, XPS analysis of the samples was done, as shown in Fig. 3, S2 andS3 in the ESI.† The peaks of Ti, C, O, F were clearly detected in survey patterns, shown in Fig. S3.† And the peaks corresponding to Al were missing, confirming complete etching.⁴⁰ In the high-resolution XPS spectrum of Ti 2p (Fig. 3), the doublet at 458.3 and 464.3 eV stems from Ti–O bond, while the signals marked as C–Ti– ${\rm T_x}$ 2p_{3/2} and C–Ti– ${\rm T_x}$ 2p_{1/2} at about 455 and 461 eV are from Ti–C, Ti–F and Ti–OH bonds.⁴¹ The changes of peaks suggest the transformation of surface termination groups as the oxidation progresses. By comparing the results, it could be noticed that the ratio of Ti–O bond (at 458.3 and 464.3 eV) increased when ${\rm Ti_3C_2T_x}$ was subjected to light oxidation, which was confirmed by the growth of TiO₂ on the surface of flakes. When the ${\rm Ti_3C_2T_x}$ was heavily oxidized,

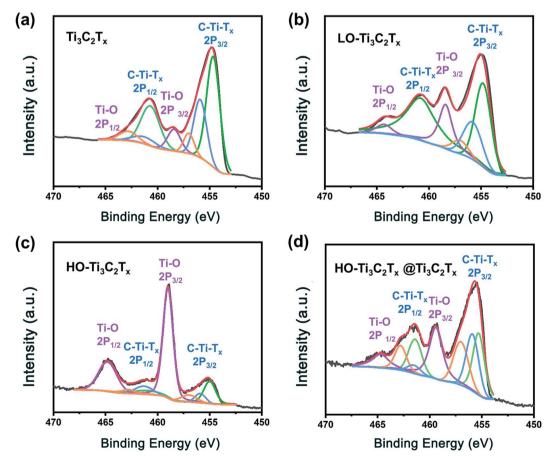


Fig. 3 Ti 2p core level XPS spectra of the films of (a) $Ti_3C_2T_x$, (b) LO- $Ti_3C_2T_x$, (c) HO- $Ti_3C_2T_x$, and (d) HO- $Ti_3C_2T_x$ @ $Ti_3C_2T_x$.

a significant increase of Ti-O bonding was found (Fig. 3c). The spectrum of HO-Ti₃C₂T_r (Fig. 3c) closely matched with that of TiO₂ (shown in Fig. S2†), with the Ti-O bond accounting for the main part while traces of Ti-C, Ti-F and Ti-OH were still left in HO- $Ti_3C_2T_r$. The results demonstrate that HO- $Ti_3C_2T_r$ still kept a part of the original structure rather than being fully transformed into TiO₂ after oxidation. The HO-Ti₃C₂T_x@Ti₃C₂T_x spectrum is shown in Fig. 3d, which looks similar to LO-Ti₃C₂T_r, but the ratios of Ti-O to C-Ti-Tx are different. In Fig. 3d, Ti-O bond is enhanced compared to Ti₃C₂T_x, indicating no loss in the Ti-O bond by any chemical interaction between the two species. Overall, the results also demonstrate the structural differences between these materials, and are in agreement with other characterization results.

Photovoltaic characterization

To determine and contrast the performance of Ti₃C₂T_x before and after oxidation, and after mixing the two as the ETL in PSCs, the devices were fabricated with an architecture of ITO/ETL/ CH₃NH₃PbI₃/spiro-OMeTAD/Ag (Fig. 4a). The typical crosssectional SEM image of the PSC device made with Ti₃C₂T_r layer as an ETL is shown in Fig. 4b, from which the thickness of ETL layer was determined to be 20 \pm 3 nm. The current densityvoltage (J-V) curves of PSCs based on Ti₃C₂T_x, LO-Ti₃C₂T_x, HO-Ti₃C₂T_x, HO-Ti₃C₂T_x@Ti₃C₂T_x and TiO₂ are given in Fig. 4c and the corresponding photovoltaic parameters including J_{sc} , opencircuit voltage (V_{oc}) , FF, and PCE were summarized in Table 1.

Table 1 The photovoltaic performance parameters of PSCs based on ETLs under different conditions

ETL	V _{oc} (V)	$J_{\rm sc}~({ m mA~cm}^{-2})$	FF (%)	PCE (%)
Ti ₃ C ₂ T _r	1.07	22.35	69	16.50
$LO-Ti_3C_2T_x$	1.06	23.04	70	17.09
$HO-Ti_3C_2T_x$	1.06	22.18	66	15.52
$HO-Ti_3C_2T_x@Ti_3C_2T_x$	1.07	23.11	74	18.29
TiO_2	1.03	20.61	70	14.86

As the data indicates, PCE of the device based on LO-Ti₃C₂T_x (17.09%) was a bit higher than that of $Ti_3C_2T_x$ (16.50%), which was reflected in the increase of J_{sc} and FF. LO-Ti₃C₂T_x keeps the monolayered-structure and good mobility of Ti₃C₂T_x while the TiO2 makes the film surface more homogenous, leading to higher J_{sc} and FF. When the $Ti_3C_2T_x$ got heavily oxidized, the 2D structure was mostly replaced with TiO2 nanoparticles, as explained above, thus the conductivity of material was decreased, making the $J_{\rm sc}$ and FF decline. As a result, PCE of the device based on HO-Ti₃C₂T_x was 15.52%. Moreover, the device based on low-temperature-processed TiO₂ made from isopropyl titanate was also fabricated and a PCE of 14.86% was obtained, which was in agreement with previous reports. 42,43 Compared with TiO2 made from isopropyl titanate, the device based on $HO-Ti_3C_2T_x$ had better J_{sc} and V_{oc} due to its higher electron mobility, which will be discussed later. Besides, the *J-V* curves

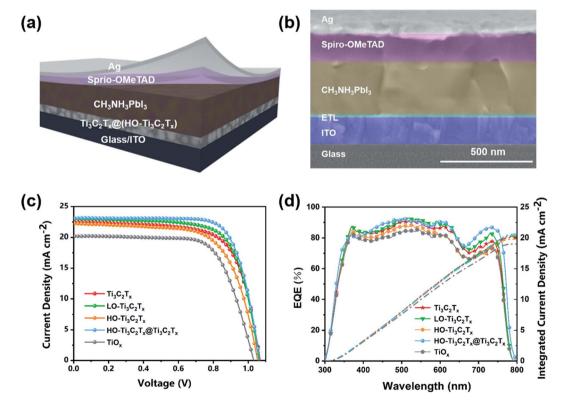


Fig. 4 (a) Device architecture of ITO/ETL/CH₃NH₃Pbl₃/spiro-OMeTAD/Ag based on representative HO-Ti₃C₂T_x@Ti₃C₂T_x as ETL, (b) crosssectional SEM image of the PSC device, (c) reverse scan of PSCs' J-V curves based on $Ti_3C_2T_x$, $LO-Ti_3C_2T_x$, LO-Tiand TiO_2 as ETLs under AM 1.5 G simulated illumination, and (d) their external quantum efficiency (EQE) spectra and the corresponding integrated current densities.

of PSCs based on HO-Ti $_3$ C $_2$ T $_x$ @Ti $_3$ C $_2$ T $_x$ with different volume ratios of 1:1, 5:1, 10:1 are shown in Fig. S4† and the corresponding photovoltaic performance parameters are summarized in Table S1.† As the combination of HO-Ti $_3$ C $_2$ T $_x$ and monolayer Ti $_3$ C $_2$ T $_x$, the film of HO-Ti $_3$ C $_2$ T $_x$ @Ti $_3$ C $_2$ T $_x$ possessed high conductivity of the monolayer MXene and the semiconductor property of HO-Ti $_3$ C $_2$ T $_x$, which is discussed later, sourcing the increase in PCE in comparison to the devices based on Ti $_3$ C $_2$ T $_x$ and HO-Ti $_3$ C $_2$ T $_x$. The best PCE of 18.29% was obtained for an optimal volume ratio of 5:1 (HO-Ti $_3$ C $_2$ T $_x$: Ti $_3$ C $_2$ T $_x$). The discussion in the following paragraphs refers to HO-Ti $_3$ C $_2$ T $_x$ @Ti $_3$ C $_2$ T $_x$ with 5:1 volume ratio.

Fig. S5† shows the photovoltaic parameter statistics of (a) V_{oc} , (b) J_{sc} , (c) FF and (d) PCE for the investigated PSCs based on $\text{Ti}_3\text{C}_2\text{T}_x$, $\text{LO-Ti}_3\text{C}_2\text{T}_x$, $\text{HO-Ti}_3\text{C}_2\text{T}_x$, $\text{HO-Ti}_3\text{C}_2\text{T}_x$ and TiO_2 . The results have a small standard deviation and show good reproducibility of devices.

The EQE spectra (Fig. 4d) and integrated currents calculated for ETLs with Ti₃C₂T_x, LO-Ti₃C₂T_x, HO-Ti₃C₂T_x, HO-Ti₃C₂T_x@Ti₃C₂T_x and TiO_2 (Fig. 4d) are in line with the changes in J_{sc} . The integrated current density from EQE curves for the device based on Ti₃C₂T_x was 20.10 mA cm⁻². A little increase of integrated current density, which was up to 20.33 mA cm $^{-2}$, was achieved with the LO-Ti₃C₂T_x film. That of HO-Ti₃C₂T_x and TiO₂ were calculated to be 19.82 mA ${\rm cm}^{-2}$ and 18.91 mA ${\rm cm}^{-2}$, respectively. For the best device based on HO-Ti₃C₂T_x@Ti₃C₂T_x, the integrated current density obtained was 20.66 mA $\,\mathrm{cm}^{-2}$. The deviation of integrated current from EQE patterns and the actual measured I_{sc} values (Table 1) is about 10%, demonstrating good matching with the J-V obtained values. Moreover, the hysteresis patterns of reverse and forward scans of J-V curves are shown in Fig. S6.† The hysteresis is about 23% for the devices based on LO-Ti₃C₂T_x, HO-Ti₃C₂T_x and HO-Ti₃C₂T_x@Ti₃- C_2T_x , which is less than the devices based on $Ti_3C_2T_x$ (27%) in our previous work.35 On the other hand, the TiO2-based device exhibited a hysteresis of 31%. The reduced hysteresis is attributed

to less surface defects and high electron mobility of the films, which promote electron transfer and prevent recombination at the ETLs/perovskite interface. Moreover, steady-state power output and current density measurements of devices based on (a) ${\rm Ti}_3{\rm C}_2{\rm T}_x$, (b) ${\rm LO}\text{-}{\rm Ti}_3{\rm C}_2{\rm T}_x$, (c) ${\rm HO}\text{-}{\rm Ti}_3{\rm C}_2{\rm T}_x$, (d) ${\rm HO}\text{-}{\rm Ti}_3{\rm C}_2{\rm T}_x$ @ ${\rm Ti}_3{\rm C}_2{\rm T}_x$ and (e) ${\rm TiO}_2$ for more than 500 s were obtained (Fig. S7†). All the devices exhibited stable output power that was in good consistence with the values determined form J-V results.

To understand the changes in energy levels caused by oxidation, five model structures of Ti₃C₂T_x, LO-Ti₃C₂T_x, HO-Ti₃C₂T_x, HO-Ti₃C₂T_x@Ti₃C₂T_x and TiO₂ were fabricated, as shown in Fig. 5. The calculations results shown in Fig. 6a suggest that $Ti_3C_2T_x$ is a metallic material with the work function of about -5.35 eV, in agreement with the previously reported value.33 After light oxidation of Ti₃C₂T_x, LO-Ti₃C₂T_x still keeps the metallic properties, while the work function shifted to -6.88 eV, owing to the newly formed TiO₂. This also supports the experimental results presented above, which showed TiO₂ nanoparticles on the surface of flakes, which still maintained conductive MXene layers. HO-Ti₃C₂T_x is almost completely transformed into TiO2 and became a semiconductor whose highest occupied molecular orbital (HOMO) and lowest unoccupied molecular orbital (LUMO) are determined as -7.23 eV and -3.26 eV, respectively. After mixing with $Ti_3C_2T_x$, the energy level of HO-Ti₃C₂T_x@Ti₃C₂T_x shifted further, HOMO and LUMO were calculated to be -7.37 eV and -3.43 eV. In addition, the HOMO and LUMO of TiO2 are obtained to be -7.92 eV and -3.69 eV. Moreover, the UPS tests of HO-Ti₃C₂T_r, HO-Ti₃C₂-Tx@Ti₃C₂Tx and TiO₂ films spin-coated onto ITO substrates were also obtained as shown in Fig. S8.† The HOMO energy levels were determined by the intersection of baseline with the tangent line of the spectra and LUMO were calculated by the results of UV-vis absorption spectra, while the schematic diagram of devices' each layer based on different ETLs were summarized in Fig. 6b. Although there were some deviations in

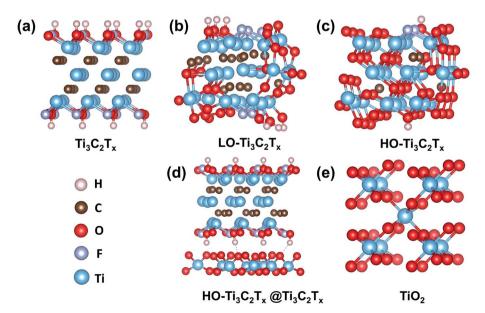


Fig. 5 Predicted crystal structures of Ti₃C₂T_x, LO-Ti₃C₂T_x, HO-Ti₃C₂T_x, HO-Ti₃C₂T_x and TiO₂ carried out by VASP code based on DFT.

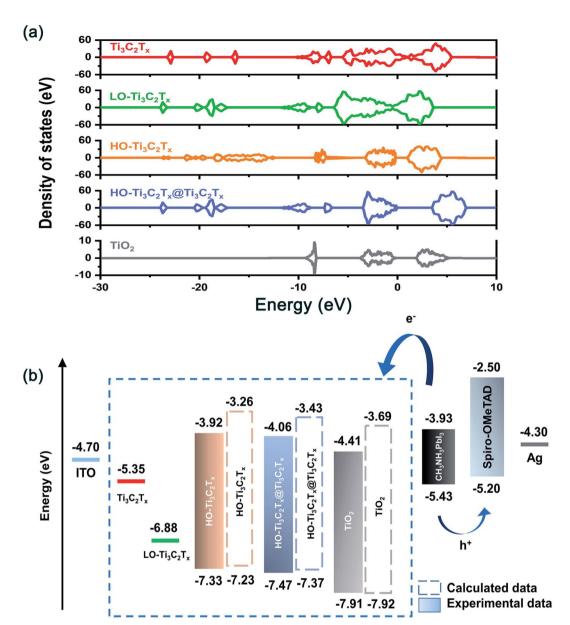


Fig. 6 (a) Calculated density of states for Ti₃C₂T_x, LO-Ti₃C₂T_x, HO-Ti₃C₂T_x, HO-Ti₃C₂T_x, TiO₂ and (b) schematic diagram of devices' each layer based on different ETLs determined by DFT calculation and UPS data.

the calculated results, overall DFT results well agreed with the experimental data by showing the shift in the trends of energy level confirming the transformation from metallic to semiconductor.35,44 HO-Ti₃C₂T_x@Ti₃C₂T_x exhibits property of semiconductor and appropriate energy level to reduce recombination at the ETLs/perovskite interface, with the addition of inserted $Ti_3C_2T_x$ to further increase the electron mobility. Thus, it is coherent that the device based on HO-Ti₃- C_2T_x a $Ti_3C_2T_x$ indicates the best PCE of 18.29%.

To investigate the electron extraction abilities of Ti₃C₂T_x, LO- $Ti_3C_2T_x$, $HO-Ti_3C_2T_x$, $HO-Ti_3C_2T_x$ and TiO_2 , the PL spectra of the CH3NH3PbI3 perovskite layer spin-coated onto ITO/ETLs substrates were measured and shown in Fig. S9a.† The PL signal at about 780 nm is assigned to the emission from CH₃NH₃PbI₃ (excitation at 403 nm) and its quenching is

originated from electron extraction across the perovskite/ETL interface. The ITO/LO-Ti₃C₂T_x/perovskite sample exhibits lower PL intensity than that of ITO/Ti₃C₂T_x/perovskite, while ITO/HO-Ti₃C₂T_x/perovskite shows higher PL intensity than that of ITO/ Ti₃C₂T_x/perovskite, indicating that low oxidation of Ti₃C₂T_x enhances the electron extraction and suppresses carrier recombination, but high oxidation turns out to have the opposite effect. Appropriate oxidation can make the Ti₃C₂T_x film exhibit semiconductor properties of TiO₂ while keeping the high conductivity. On the other hand, HO-Ti₃C₂T_x deteriorates the monolayeredstructure and shows low conductivity. Moreover, the PL intensity of ITO/TiO2/perovskite sample is higher than that of ITO/HO-Ti₃C₂T_r/perovskite, demonstrating that although the monolayered structure is no longer present, HO-Ti₃C₂T_x still shows better electron extraction than TiO₂ fabricated by isopropyl titanate. Besides,

the ITO/HO-Ti $_3C_2T_x$ @Ti $_3C_2T_x$ /perovskite exhibits the lowest PL intensity, indicating that HO-Ti $_3C_2T_x$ @Ti $_3C_2T_x$ offers the best electron extraction from the perovskite to the ETL among these five kinds of samples. The combination of HO-Ti $_3C_2T_x$ and Ti $_3C_2T_x$ effectively enhanced electron transport and suppressed carrier recombination owing to its integrated monolayered structure and suitable semiconductor property of HO-Ti $_3C_2T_x$. In addition, the TRPL spectra of perovskites based on these ETLs were shown in Fig. S9b.† The lifetimes of PL decay of Ti $_3C_2T_x$, LO-Ti $_3C_2T_x$, HO-Ti $_3C_2T_x$ @Ti $_3C_2T_x$ and TiO $_2$ -based perovskites were determined as 101.1 ns, 112.3 ns, 124.5 ns, 78.2 ns and 165.7 ns, respectively. These were consistent with the PL results, further demonstrating the results of *J-V* curves and EQE spectra.

Electron mobility values of $Ti_3C_2T_x$, LO- $Ti_3C_2T_x$, HO- $Ti_3C_2T_x$, HO- $Ti_3C_2T_x$ and TiO_2 were tested by the method of space charge-limited current (SCLC) on the devices with the electron-only structure of ITO/SnO $_2$ /ETL/BCP/Ag under dark (Fig. S10†). The electron mobility of $Ti_3C_2T_x$, LO- $Ti_3C_2T_x$, HO- $Ti_3C_2T_x$ @Ti $_3C_2T_x$, TiO $_2$ was determined as 1.29 × 10^{-5} cm $_2^2$ V $_2^{-1}$ s $_2^{-1}$, 1.76 × 10^{-5} cm $_2^2$ V $_2^{-1}$ s $_2^{-1}$, 1.30 × 10^{-5} cm $_2^2$ V $_2^{-1}$ s $_2^{-1}$, 1.82 × 10^{-5} cm $_2^2$ V $_2^{-1}$ s $_2^{-1}$ and 7.67 × 10^{-6} cm $_2^2$ V $_2^{-1}$ s $_2^{-1}$ respectively. The device based on HO- $Ti_3C_2T_x$ @Ti $_3C_2T_x$ exhibited the best mobility and also yielded the best PCE. The mobility results effectively explain the improvement in J_{sc} and FF values in the device and accord with the results of J_2 . EQE and PL.

To demonstrate whether the difference in FF is associated with interfacial charge transfer, EIS measurement was employed on devices with the structure of ITO/ETLs/CH3NH3PbI3/spiro-OMeTAD/Ag. Fig. S11† exhibits the Nyquist plots of the five devices and the equivalent circuit model that fits the experimental data with the frequency ranging from 1 MHz to 10 Hz under the standard AM 1.5 G (100 mW cm⁻²) simulated sunlight illumination. Besides, the fitted data is shown in Table S2.† R_1 represents the series resistance associated with external wires and the ITO substrate, while the semi-circle represents the interfacial charge transfer resistance (R_2) and capacitance (C) at the interface of ETLs/ perovskite. R_2 follows the order of $TiO_2 > HO-Ti_3C_2T_x > Ti_3C_2T_x > Ti_3C$ LO-Ti₃C₂T_x > HO-Ti₃C₂T_x@Ti₃C₂T_x. The lowest R_2 of 188.2 Ω is achieved by the device based on HO-Ti₃C₂T_x@Ti₃C₂T_x, indicating the highest electrons collection and the lowest charge transfer resistance at the interface, thus generating the highest FF, which is also in good accordance with *I-V* curves.

Besides, the stability of devices based on different ETLs was also studied and the results are shown in Fig. S12.† The devices were placed in ambient air (25 °C, relative humidity $\approx 20\%$) without encapsulation and tested under the standard AM 1.5 G (100 mW cm $^{-2}$) simulated sunlight illumination. All the devices exhibited good stability and similar downtrend, the efficiency of TiO₂-based device reduced to 64% after 800 h of storage while the other PSCs based on Ti₃C₂T_x and oxidized Ti₃C₂T_x showed better stabilities, retaining from 65% to 69% of the initial values. And, the HO-Ti₃C₂T_x@Ti₃C₂T_x-based device retained 71% of the initial PCE. Moreover, both LO-Ti₃C₂T_x and HO-Ti₃C₂T_x had good stability, demonstrating the oxidation has no negative impact on the devices' stability. The results also revealed that Ti₃C₂T_x had a certain passivation impact, which could decrease the chemical activity at the interface of

perovskite/ETLs and suppress the hydration reaction.⁴⁵ Thus, the appropriate combination of HO-Ti $_3$ C $_2$ T $_x$ and Ti $_3$ C $_2$ T $_x$ effectively improved the stability of devices, presenting its high potential for application in PSCs.

Conclusion

Oxidation of 2D Ti₃C₂T_r MXene in solution was used to produce ETLs with improved properties. Oxidation of Ti₃C₂T_x can reduce the defects of the film fabricated by spin-coating and generate more Ti-O bonds. The structures of oxidized Ti₃C₂T_r were simulated and the calculations of energy levels by the VASP code based on DFT were carried out. A transition from metal to semiconductor occurred after heavy oxidation, leading to a better matching of energy levels between ETLs and perovskite, thus rendering oxidized $Ti_3C_2T_x$ more suitable as ETLs in PSCs. A PCE of 18.29% was achieved for PSCs using a composite of heavily oxidized and pristine Ti₃C₂T_x as ETL, in comparison with PSCs using pristine Ti₃C₂T_x as ETL which showed a PCE of 16.50%. The enhancement of PCE can be explained by facilitated electron transport and reduced recombination at the ETL/ perovskite interface due to the reduced defects of film surface and the increase of electron mobility. This work shows that modification of MXenes can improve their performance in PSCs and other photovoltaic technologies.

Author contributions

L. Y. conducted the experimental work, D. K. and Y. W. conducted theoretical calculation work, C. D., Y. D., A. J. and G. C. provided experimental instruction, B. W. provided experimental help, and X.-F. W. conceived the research idea, X.-F. W., Y. G., and T. M. guided the work. All authors contributed to the discussion of the results and edited the manuscript.

Conflicts of interest

The authors declare no conflict of interest.

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